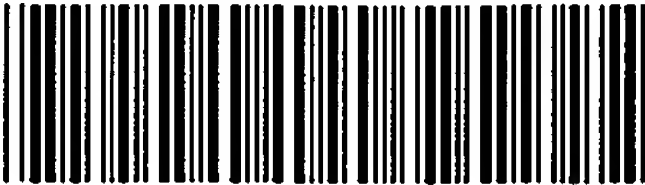


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/665,701	KIM ET AL.	
	Examiner	Art Unit	
	Aung T. Win	2617	

SEARCHED			
Class	Subclass	Date	Examiner
455	136-449	3/4/2007	ATW
455	450-454	3/4/2007	ATW
455	522	3/4/2007	ATW
370	330-332	3/4/2007	ATW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
keyword search and combination search with listed subclasses	03/04/2007	ATW